



FCC RF Test Report

Product Name: LTE USB Rotator

Model Number: E3276s-500

**Report No: SYBH(Z-RF)013092012-2004
FCC ID: QISE3276S-500**

Reliability Laboratory of Huawei Technologies Co., Ltd.

Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District,
Shenzhen, 518129, P.R.C
Tel: +86 755 28780808 Fax: +86 755 89652518

Notice

1. The laboratory has obtained the accreditation of China National Accreditation Service for Conformity Assessment (CNAS), and accreditation number: L0310.
2. The laboratory has passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
3. The laboratory has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements. The site recognition number is 97456.
4. The laboratory has been listed by industry Canada to perform electromagnetic emission measurement. The site recognition number is 6369A-2.
5. The test report is invalid if not marked with "exclusive stamp for the test report".
6. The test report is invalid if not marked with the stamps or the signatures of the persons responsible for performing, revising and approving the test report.
7. The test report is invalid if there is any evidence of erasure and/or falsification.
8. If there is any dissidence for the test report, please file objection to the test centre within 15 days from the date of receiving the test report.
9. Normally, the test report is only responsible for the samples that have undergone the test.
10. Context of the test report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of the laboratory.



Contents

1	<u>General Information</u>	5
1.1	APPLIED STANDARD.....	5
1.2	TEST LOCATION.....	5
1.3	TEST ENVIRONMENT CONDITION	5
2	<u>Summary</u>	6
3	<u>Product Description</u>	7
3.1	PRODUCT INFORMATION	7
4	<u>Test Description</u>	9
4.1	SUPPORTED FREQUENCY RANGE	9
4.2	TRANSMITTER / RECEIVER CHARACTERISTICS.....	9
4.3	ANTENNA GAIN.....	9
5	<u>General Test Conditions / Configurations</u>	10
5.1	RF CHANNELS UNDER TEST	10
5.2	TEST MODES.....	10
5.3	TEST ENVIRONMENT	11
5.4	TEST SETUP.....	12
5.5	TEST CONDITIONS	16
6	<u>Main Test Instruments</u>	17
7	<u>Test Results</u>	18
8	<u>Measurement Uncertainty</u>	18



1 General Information

1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 02 (10-1-11 Edition)
47 CFR FCC Part 27 (10-1-11 Edition)

Test Method: FCC KDB 971168 D01 Power Meas License Digital Systems v01
FCC KDB 662911 D01 Multiple Transmitter Output v01

1.2 Test Location

Test Location 1: Reliability Laboratory of Huawei Technologies Co., Ltd.
Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,
Bantian, Longgang District, Shenzhen, 518129, P.R.C

1.3 Test Environment Condition

Ambient Temperature: 19.5 to 25 °C
Ambient Relative Humidity: 45to 55%
Atmospheric Pressure: Not applicable

2 Summary

Table 1 Summary of Band 7 results

Test Case	FCC Part No.	Requirements	Result
BRS&EBS Band			
Transmitter Output Power	2.1046 & 27.50(h)(2)	Peak EIRP not exceed 2 W Peak-to-average ratio not exceed 13 dB	Pass
Modulation Characteristics	2.1047	Digital modulation	Pass
Occupied Bandwidth	2.1049	(Not specified)	Pass
Band Edges Compliance	2.1051 & 27.53(m)(4) & 27.53(m)(6)	Below -13 dBm/1%*EBW, in 1 MHz range Below -13 dBm/1 MHz, in 1 MHz to 5.5Mhz range	Pass
Spurious Emission at Antenna Terminals	2.1051 & 27.53(m)(2) & 27.53(m)(6)	Below -13 dBm/1 kHz, 9 kHz to 150 kHz Below -13 dBm/10 kHz, 150 kHz to 30 MHz Below-25 dBm/1 MHz, 30 MHz to 10 th harmonics	Pass
Field Strength of Spurious Radiation	2.1053 & 27.53(m)(2) & 27.53(m)(6)	Below -25 dBm/1 MHz	Pass
Frequency Stability	2.1055 & 27.54	Stay within the authorized bands of operation	Pass

3 Product Description

3.1 Product Information

3.1.1 General Description

E3276s-500 USB Rotator is subscriber equipment in the LTE/ DC-HSPA+/ HSUPA/ HSDPA/ WCDMA/ EDGE/ GPRS/ GSM system. LTE supports Band II, IV, V, VII. E3276s-500 implement such functions as RF signal receiving/ transmitting, LTE/ HSPA+/ WCDMA and EDGE/ GPRS/ GSM protocol processing, data service etc. Externally it provides USB interface (to connect to the notebook etc.), USIM card interface and Micro SD card interface. E3276s-500 has an internal antenna as default.

NOTE:

- 1) : We retest W850、 LTE Band 2 and Band 5 , the other testing reports used E3276s-151.
- 2) : The difference of E3276s-500 and E3276s-151:
 1. E3276s-151 is a LTE/DC-HSPA+/HSUPA/HSDPA/EDGE/GPRS/GSM USB Rotator. The GSM supports four bands. The WCDMA supports WCDMA1900 and WCDMA 1700. LTE supports B4 and B7.
 2. E3276s-500 is the USB Rotator which changes some components from E3276s-500. The PCB of E3276s-500 and E3276s-151 is the same.

The differences between E3276s-500 and E3276s-151 are: E3276s-500 add WCDMA 850 and LTE B2、 B5 components.

The followed table is show the different between the 2 Models.

	E3276s-500	E3276s-151
GSM four band	support	support
WCDMA 1900M	support	support
WCDMA AWS	support	support
WCDMA 850M	support	No
LTE B2(1900M)	support	No
LTE B4(1700M)	support	Support
LTE B5(850M)	support	No
LTE B7(2600M)	support	support
FLASH	Support 256M	Support 256M
PCB	the same	the same
Appearance	Common Appearance	Common Appearance



3.1.2 Board Information

Table 2 Board Information

LTE USB Rotator		
E3276s-500		
Board and Module		
Description	Hardware Version	Serial Number
MAINBOARD	CH1E3276SM	V7U01A9291400086



4 Test Description

4.1 Supported Frequency Range

Characteristics	Description
Downlink	2620 to 2690 MHz;
Uplink	2500 to 2570 MHz;

4.2 Transmitter / Receiver Characteristics

Characteristics	Description
System Type	LTE
TX Output Power (per Antenna Port)	LTE system: 23dBm
Channel Spacing(s) / Bandwidth(s)	LTE system: 5 MHz, 10 MHz, 15 MHz, 20 MHz
Designation of Emissions	LTE system: 4M47G7D (5 MHz ,QPSK modulation), 4M46W7D (5 MHz ,16QAM modulation), 8M93G7D (10 MHz QPSK modulation), 8M95W7D (10 MHz 16QAM modulation), 13M4G7D (15MHz QPSK modulation), 13M4W7D (15MHz 16QAM modulation), 17M8G7D (20 MHz QPSK modulation), 17M8W7D (20 MHz 16QAM modulation),

4.3 Antenna Gain

Antenna Gain(dBi) to LTE Band 7	3.3
---------------------------------	-----

5 General Test Conditions / Configurations

5.1 RF Channels under Test

Test Mode	TX / RX	RF Channel		
		Low (B)	Middle (M)	High (T)
LTE Band 7	TX (5M)	Channel 20775	Channel 21100	Channel 21425
		2502.5 MHz	2535 MHz	2567.5 MHz
	TX (10M)	Channel 20800	Channel 21100	Channel 21400
		2505 MHz	2535 MHz	2565 MHz
	TX (15M)	Channel 20825	Channel 21100	Channel 21375
		2507.5 MHz	2535 MHz	2562.5 MHz
	TX (20M)	Channel 20850	Channel 21100	Channel 21350
		2510 MHz	2535 MHz	2560 MHz
	RX (5M)	Channel 2775	Channel 3100	Channel 3425
		2622.5 MHz	2655 MHz	2687.5 MHz
	RX (10M)	Channel 2800	Channel 3100	Channel 3400
		2625 MHz	2655 MHz	2685 MHz
	RX (15M)	Channel 2825	Channel 3100	Channel 3375
		2627.5 MHz	2655 MHz	2682.5 MHz
	RX (20M)	Channel 2850	Channel 3100	Channel 3350
		2630 MHz	2655 MHz	2680 MHz

5.2 Test Modes

Test Mode	Test Modes Description
TM1	LTE QPSK modulation
TM2	LTE 16QAM modulation



5.3 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	Ambient	
Temperature	TN	Ambient
Voltage	VL	4.75V
	VN	5.0V
	VH	5.25V

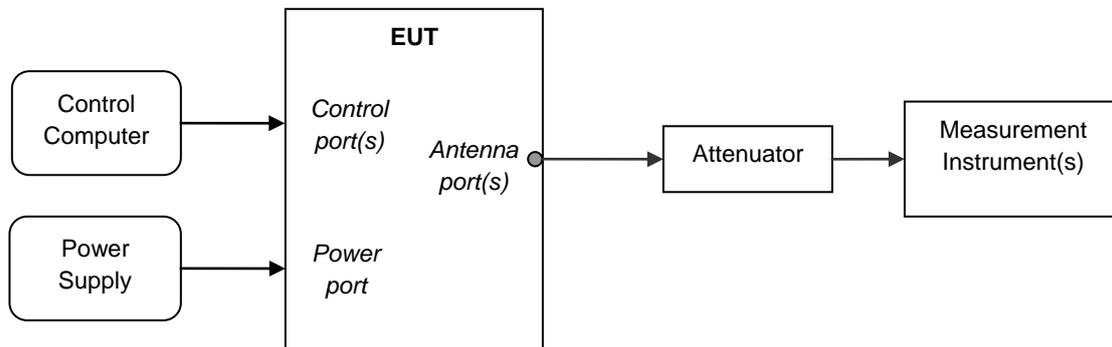
NOTE: VL= lower extreme test voltage
VN= nominal voltage
VH= upper extreme test voltage
TN= normal temperature

5.4 Test Setup

5.4.1 General Test Setup Configurations

Configuration	Description
Test Antenna Ports	Until otherwise declared, all TX tests are ONLY performed at the main Transmitter antenna port (e.g. TRXA, TXA and so on) of the EUT, and all RX tests are ONLY performed at the main Receiver antenna port (e.g. TRXA, RXA and so on) of the EUT.
Multiple RF Sources	Other than the tested RF source of the EUT, other RF source(s) are disabled or shutdown during measurements.

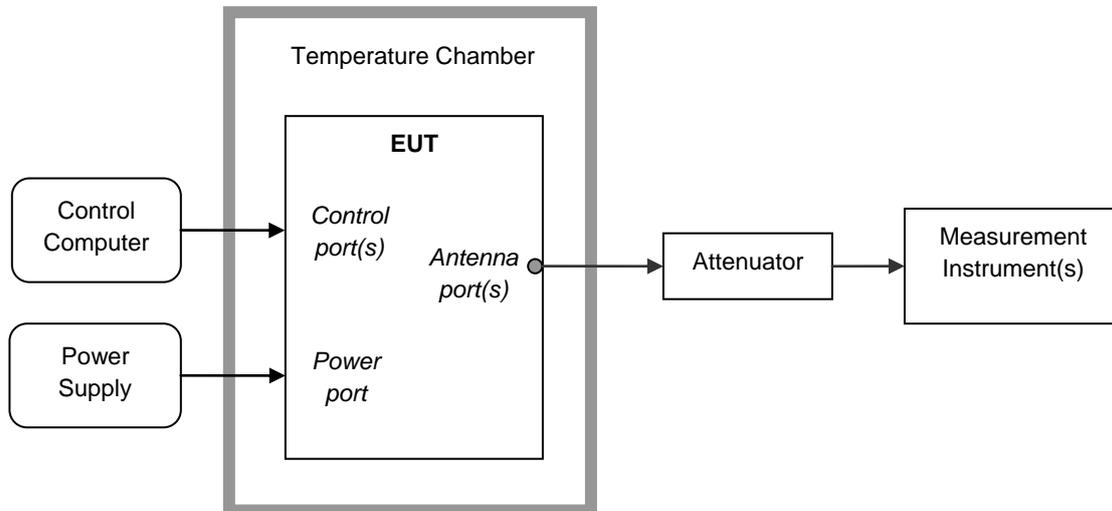
5.4.2 Test Setup 1



Note:

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

5.4.3 Test Setup 2



5.4.4 Test Setup 3

NOTE1: Effective radiated power (ERP) or Effective Isotropic radiated power (EIRP) refers to the EUT radiation power output, assuming all emissions are radiated from half-wave dipole antennas or horn antennas.

NOTE2: The EUT was set on insulator 80cm above the Ground Plane. The setup and test methods were according to ANSI-TIA-603C 2004. The measurements were carried through with a Rohde and Schwarz Test Receiver and control software.

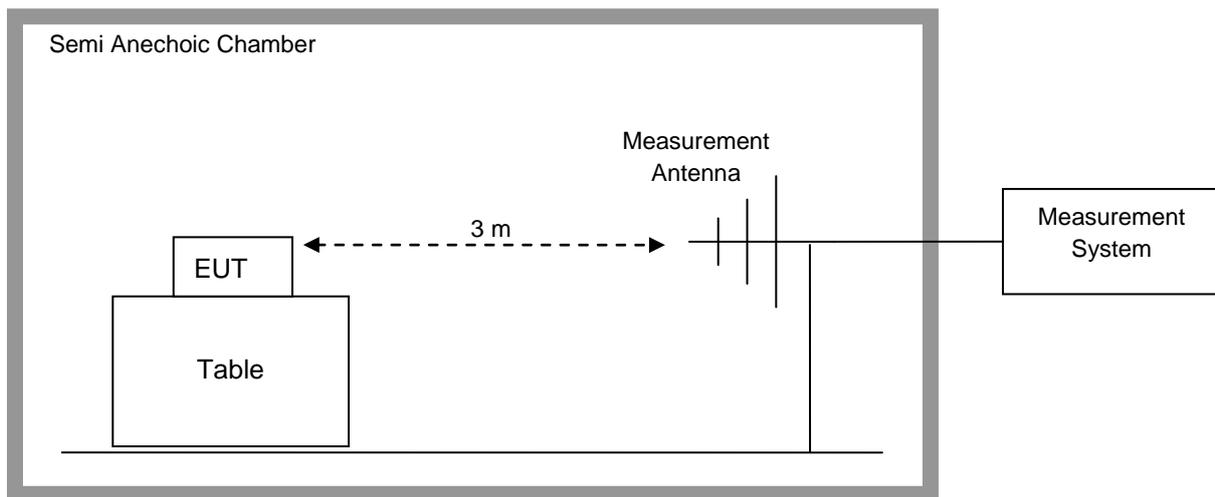
Step 1: Pre-test to find the Maximum ERP or EIRP

1. Connect the test system according to the following figure. EUT is running for 30 minutes before test, and measurement instruments are warming-up for 30 minutes.
2. Set up communication link between Universal radio communication tester and EUT, set EUT working frequency, and control EUT to transmit at maximum power.
3. Set the center frequency of the signal analyzer or receiver to the EUT's operating frequency, the RBW is equal to the emission bandwidth of the signal. Set RMS detector for the test, and the span is

equal to 2 times of emission bandwidth, the other settings should remain automatic. Normally, the height range of antenna was 1m to 4m, the azimuth range of turntable was 0°to 360°. The receiver antenna has two polarizations V and H. A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

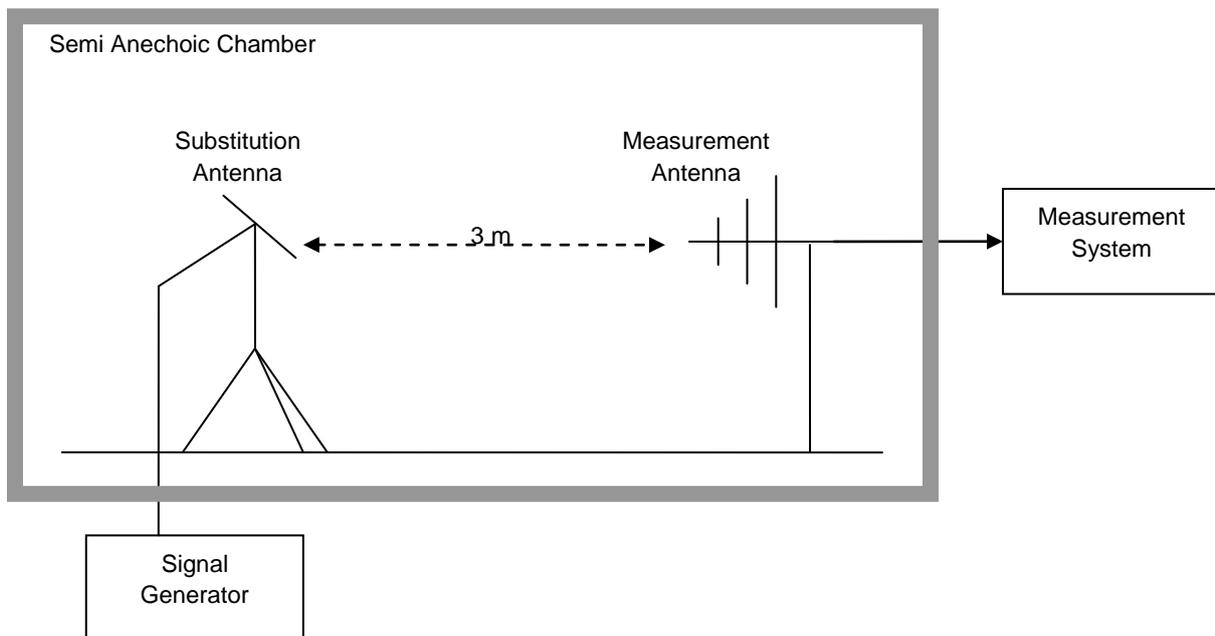
4. Changing EUT working frequency and measuring the RF power at channel L, M, H respectively.

Complete the test data.



Step 2: Substitution method to verify the maximum ERP or EIRP

1. Measurement setup is according to the following figure. EUT was substituted by antenna, and the polarization is identical with the test antenna; the signal generator was connected to the substitution antenna.
2. The radiated output power, measured by signal analyzer set, is the same as recorded in above. Then this power level is matched by a signal from a calibrated signal generator which is substituted for EUT. The power supplied by the generator is then equal to the ERP or EIRP after corrected by the antenna gain and cable loss.



5.5 Test Conditions

Test Case	Test Conditions	
Transmitter Output Power	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1 & Test Setup 3
	Detector	RMS
	RF Channels (TX)	B, M, T
	Test Mode	TM1/TM2
Modulation Characteristics	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	M
	Test Mode	TM1/TM2
Occupied Bandwidth	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	RMS
	RF Channels (TX)	B, M, T
	Test Mode	TM1/TM2
Band Edges Compliance	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	RMS
	RF Channels (TX)	B, T
	Test Mode	TM1/TM2
Spurious Emission at Antenna Terminals	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	PK
	RF Channels (TX)	B, M, T
	Test Mode	TM1
Field Strength of Spurious Radiation	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 3
	Detector	PK
	RF Channels (TX)	M
	Test Mode	TM1
Frequency Stability	Test Configuration	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) VL VN VH Voltage at Ambient Temperature.
	Test Setup	Test Setup 2
	RF Channels (TX)	M
	Test Mode	TM1/TM2

6 Main Test Instruments

Table 3 Main Test Equipments

Equipment Description	Manufacturer	Model	Serial Number	Calibrated until
Power supply	KEITHLEY	2303	1288003	Sep.27,2012
Universal Radio Communication Tester	R&S	CMU200	117341	Jan.12.2013
Universal Radio Communication Tester	Agilent	E5515C	MY50260239	Aug.31,2013
Spectrum Analyzer	Agilent	E4440A	MY49420179	Jul.17,2013
Signal Analyzer	R&S	FSQ31	200021	Sep.27,2012
Temperature Chamber	WEISS	WKL64	24600294	Feb.13,2013
Signal generator	Agilent	E8257D	MY49281095	Jul.08.2013
Spectrum analyzer	R&S	FSU3	200474	Mar., 05, 2013
Spectrum analyzer	R&S	FSU43	100144	Mar., 05, 2013
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	Apr., 05, 2013
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100391	Apr., 05, 2013
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-521	Jul., 07, 2013
Pyramidal Horn Antenna(26GHz-40GHz)	ETS-Lindgren	3160-10	00123940	Feb., 27, 2013
Pyramidal Horn Antenna(18GHz-26.5GHz)	ETS-Lindgren	3160-09	00125912	Feb.,27, 2013
Universal Radio Communication Tester	R & S	CMW500	20347676	Sept., 07, 2012
Universal Radio Communication Tester	Anritsu	MT8820C	6200971028	May., 04, 2013

NOTE: The Appendix I is only photos Field Strength of Spurious Radiation and Receiver Spurious Emissions test setup, no test data.

7 Test Results

No.	Test Item	Test Result
1	Transmitter Output Power	Appendix A
2	Modulation Characteristics	Appendix B
3	Occupied Bandwidth	Appendix C
4	Band Edges Compliance	Appendix D
5	Spurious Emission at Antenna Terminals	Appendix E
6	Field Strength of Spurious Radiation	Appendix F
7	Frequency Stability	Appendix G
8	Photos of Test Setup	Appendix H

NOTE: There is no test data in Appendix H, only Photos of Test Setup for Field Strength of Spurious Radiation.

8 Measurement Uncertainty

For a 95% confidence level ($k=2$), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty
Transmitter Output Power	Power (dBm)	U =0.39 dB
Occupied Bandwidth	Magnitude (%)	U=0.2%
Band Edge Compliance	Disturbance Power (dBm)	U=2.0 dB
Conducted Spurious Emissions	Disturbance Power (dBm)	U=2.0 dB
Field Strength of Spurious Radiation	ERP (dBm)	U=4.6 dB (30 MHz – 1GHz) U=3.0 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy (ppm)	U=0.21 ppm

-----The END-----